

BAM! From Migration to Activation, Leveraging Bedrock and GenAl for Intelligent Document Processing

Executive Workshop

SPEAKERS



VP of Business Development & Partnerships Basis Worldwide



Joshua Corb Founder/CEO Basis Worldwide



Radhika Chakravarty Sr. GEN AI Specialist Solutions Architect

Click Here to Register



Central Time

Breakfast & Registration

9:00 AM-10:00 AM

Opening Remarks

10:00 AM-10:15 AM

OpenAl to AWS Bedrock Migration - Strategy, Architecture, and Cost Optimization

10:15 AM-10:45 AM

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This session will walk attendees through Basis' AWS Marketplace backed framework for transitioning GenAI workloads to Amazon Bedrock. Topics include BAM (Bedrock Assessment Migration tool), prompt conversion, embedding migration, cost-performance benchmarking, Bedrock model selection, model performance comparison, secure architecture provisioning using CloudFormation, and case studies across regulated industries. Ensuring an LLM provides business value whether you have existing GenAI workloads or are net new to LLMs. Hands on workshop to connect example codebase to BAM to see how assessments work

| Hands-On Lab | 10:45 AM-11:30 AM |
|---|-------------------|
| Q&A and Open Discussion | 11:30 AM-11:50 AM |
| Lunch | 11:50 AM-1:00 PM |
| Activating Migrated Data - Intelligent Document Processing with GenAl | 1:00 PM-1:30 PM |

After migration, what comes next? This session shows how to operationalize unstructured data using GenAI and AWS-native services. Attendees will explore document ingestion pipelines powered by Textract, RAG-based summarization using Bedrock and SageMaker, and vector DB integration for intelligent retrieval. Basis will present reusable patterns for IDP and walkthrough real production architectures that reduce manual effort and accelerate insights.

| Workshop Parsing Documents | 1:30 PM-2:15 PM |
|----------------------------|-----------------|
| Q&A and Open Discussion | 2:15 PM-2:30 PM |
| Networking Activity | 2:30 PM-3:30 PM |

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